

Notice of References Cited	Application/Control No. 10/655,179	Applicant(s)/Patent Under Reexamination KLUTH ET AL.	
	Examiner Long K. Tran	Art Unit 2818	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,740,605	05-2004	Shiraiwa et al.	438/795
	B	US-6,642,103	11-2003	Wils et al.	438/257
	C	US-6,596,576	07-2003	Fu et al.	438/230
	D	US-2003/0216000	11-2003	Beaman et al.	438/257
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	I	US-			
	J	US-			
	K	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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